Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,676	LIN ET AL.	
Examiner	Art Unit	
Ryan M. Stiglic	2112	

SEARCHED					
Subclass	Date	Examiner			
101	8/9/05	AS			
113					
116					
1					
240-241					
244		<u> </u>			
	Subclass 107 113 116 117 240-241	Subclass Date 107 8/9/05 113 116 117 240-241 244			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see attached search notes		88		
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